TEST REPORT

Test report no.: 1-2298/16-01-13

Deutsche Akkreditierungsstelle D-PL-12076-01-01

Testing laboratory

CTC advanced GmbH
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Accredited Testing Laboratory:
The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS)
The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-01

Applicant

Poly-Control ApS
Gammel Stillingvej 427 C
8462 Harlev / DENMARK
Phone: -/-
Fax: -/-
Contact: Henning Overgaard
e-mail: ho@poly-control.com
Phone: +45 42 42 81 22

Manufacturer

Poly-Control ApS
Gammel Stillingvej 427 C
8462 Harlev / DENMARK

Test standard/s

47 CFR Part 15	Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 210 Issue 9	Spectrum Management and Telecommunications Radio Standards Specification - Licence-Exempt Radio Apparatus: Category I Equipment
RSS - Gen Issue 4	Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

For further applied test standards please refer to section 3 of this test report.

Test Item

Kind of test item:	**Electronic door lock**
Model name:	**V3-BTZU**
FCC ID:	**2ADSH-V3BTZU**
IC:	**12588A-V3BTZU**
Frequencies:	CH 0: 916.0 MHz ; CH 1: 908.4 MHz
Technology tested:	ZWave
Antenna:	Integrated ceramic chip antenna
Power supply:	3.0 V DC by Li battery
Temperature range:	+5°C to +35°C

This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorized:

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Andreas Luckenbill
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Test performed:

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Tobias Wittenmeier
Testing Manager
Radio Communications & EMC

1 Table of contents

2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CTC advanced GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.
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2.2 Application details

Date of receipt of order:	2017-01-27
Date of receipt of test item:	2017-03-08
Start of test:	2017-05-09
End of test:	2017-05-12
Person(s) present during the test:	-/-

2.3 Test laboratories sub-contracted

None

3 Test standard/s and references

Test standard	Date	Description
47 CFR Part 15		Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 210 Issue 9	August 2016	Spectrum Management and Telecommunications Radio Standards Specification - Licence-Exempt Radio Apparatus: Category I Equipment
RSS - Gen Issue 4	November 2014	Spectrum Management and Telecommunications Radio Standards Specifications - General Requirements and Information for the Certification of Radio Apparatus

Guidance	Version	Description
ANSI C63.4-2014	-/-	American national standard for methods of measurement of radio-noise emissions from low-voltage electrical and electronic equipment in the range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American national standard of procedures for compliance testing of unlicensed wireless devices

4 Test environment

Temperature	:	T_{nom} T_{max} T_{min}	+22 °C during room temperature tests No tests under extreme conditions required No tests under extreme conditions required
Relative humidity content	:		55 %
Barometric pressure	:		1021 hpa
Power supply	:	V_{nom} V_{max} V_{min}	3.0 V DC by Li battery No tests under extreme conditions required No tests under extreme conditions required

5 Test item

5.1 General description

Kind of test item	:	Electronic door lock
Type identification	:	V3-BTZU
HMN	:	-/-
PMN	:	DANALOCK
HVIN	:	V3-BTZU
FVIN	:	V3
S/N serial number	:	No information available
HW hardware status	:	2.0.0
SW software status	:	DanalockV3_0.1.14
Frequencies	:	CH 0: 916.0 MHz ; CH 1: 908.4 MHz
Type of radio transmission Use of frequency spectrum	: :	Modulated carrier
Type of modulation	:	2-FSK
Number of channels	:	2
Antenna	:	Integrated ceramic chip antenna
Power supply	:	3.0 V DC by Li battery
Temperature range	:	22°C

5.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report: 1-2298/16-01-01_AnnexA
1-2298/16-01-01_AnnexB
1-2298/16-01-01_AnnexD

6 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

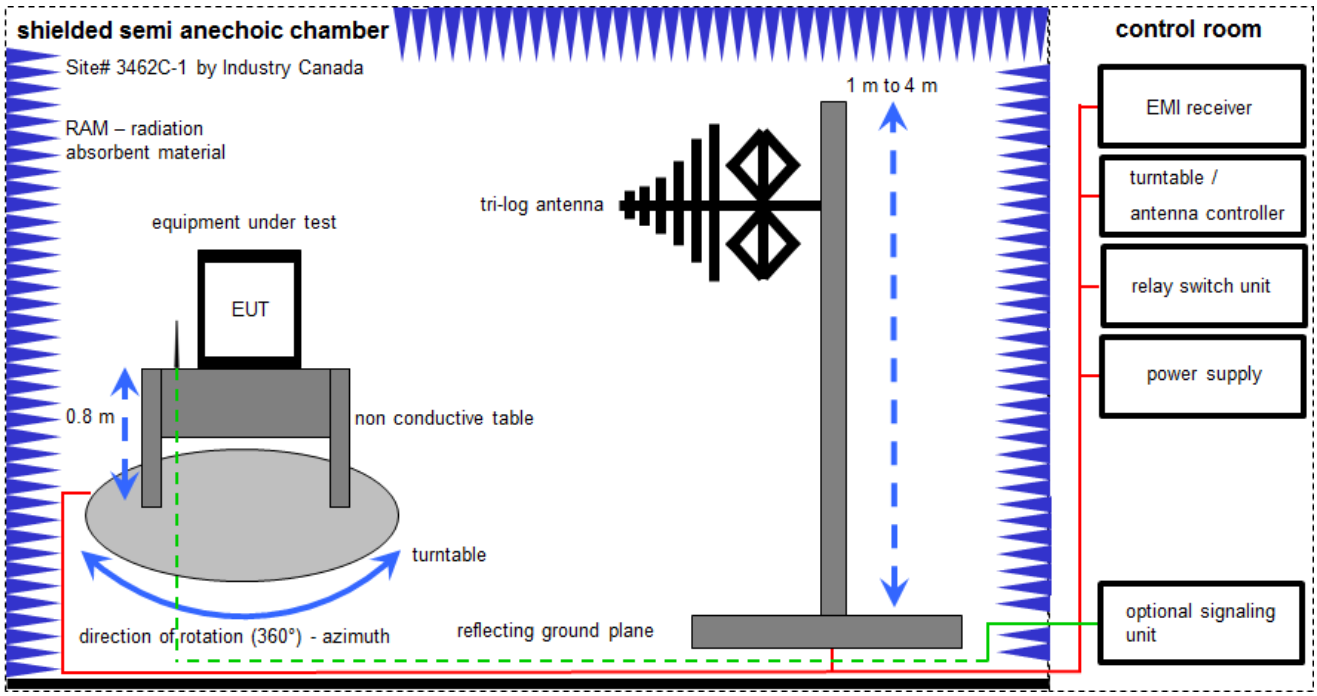
In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

k	calibration / calibrated	EK	limited calibration
ne	not required (k, ev, izw, zw not required)	zw	cyclical maintenance (external cyclical maintenance)
ev	periodic self verification	izw	internal cyclical maintenance
Ve	long-term stability recognized	g	blocked for accredited testing
vlkl!	Attention: extended calibration interval		
NK!	Attention: not calibrated	*)	next calibration ordered / currently in progress

6.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are conform to specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Measurement distance: tri-log antenna 10 meter

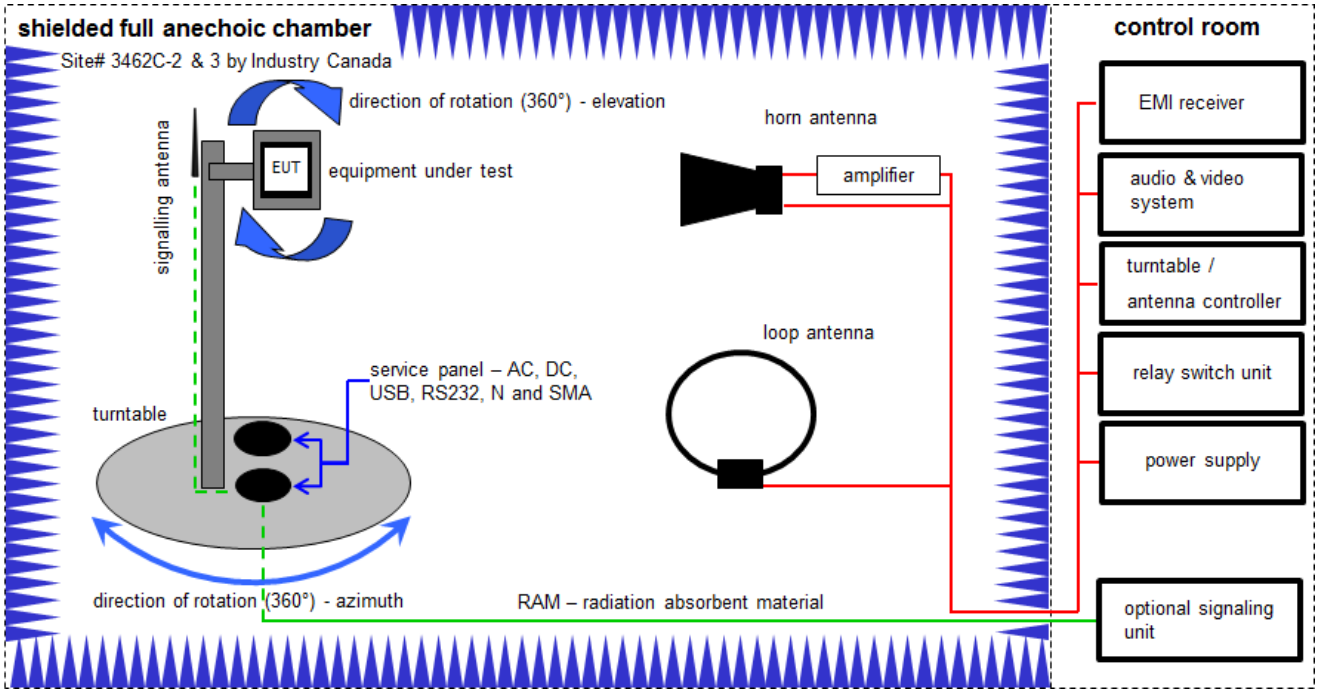
FS = UR + CL + AF
(FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

Example calculation:
FS [dBµV/m] = 12.35 [dBµV/m] + 1.90 [dB] + 16.80 [dB/m] = 31.05 [dBµV/m] (35.69 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Switch-Unit	3488A	HP	2719A14505	300000368	ev	-/-	-/-
2	A	Meßkabine 1	HF-Absorberhalle	MWB AG 300023		300000551	ne	-/-	-/-
3	A	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	01.02.2017	31.01.2018
4	A	Analyzer-Reference-System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	Ve	02.02.2016	02.02.2018
5	A	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
6	A	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
7	A	Turntable Interface-Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
8	A	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	25.04.2016	25.04.2018
9	A	Spectrum-Analyzer	FSU26	R&S	200809	300003874	k	31.01.2017	30.01.2018

6.2 Shielded fully anechoic chamber



Measurement distance: horn antenna 3 meter; loop antenna 3 meter

FS = UR + CA + AF
(FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

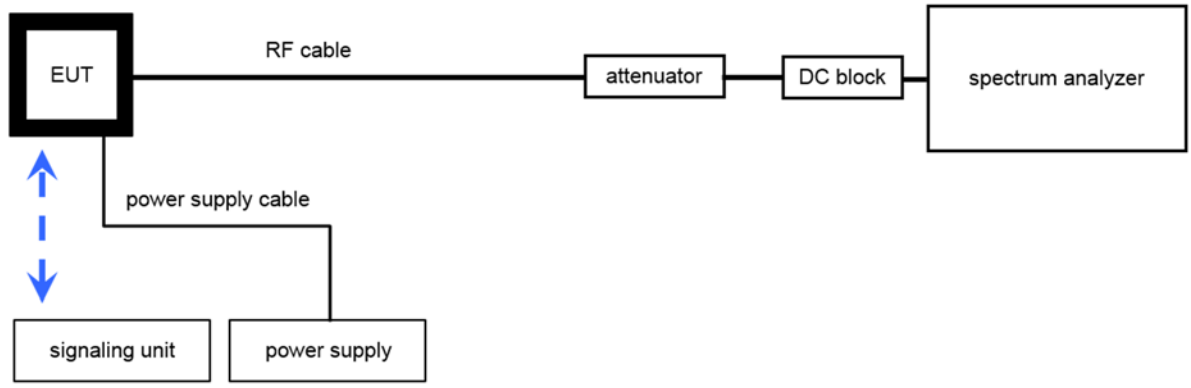
Example calculation:
FS [dBµV/m] = 40.0 [dBµV/m] + (-35.8) [dB] + 32.9 [dB/m] = 37.1 [dBµV/m] (71.61 µV/m)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO	2210	300001015	k	20.05.2015	20.05.2017
2	B	Double-Ridged Waveguide Horn Antenna 1-18.0GHz	3115	EMCO	9709-5290	300000212	k	13.08.2015	13.08.2017
3	B	Highpass Filter	WHK1.1/15G-10SS	Wainwright	37	400000148	ne	-/-	-/-
4	B	Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	300003789	ne	-/-	-/-
5	B	Broadband Amplifier 0.5-18 GHz	CBLU5184540	CERNEX	22051	300004483	ev	-/-	-/-
6	A,B	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000032	300004510	ne	-/-	-/-
7	A,B	Computer	Intel Core i3 3220/3,3 GHz, Prozessor		2V2403033A54 21	300004591	ne	-/-	-/-
8	A,B	NEXIO EMV-Software	BAT EMC V3.16.0.49	EMCO		300004682	ne	-/-	-/-
9	A,B	Anechoic chamber		TDK		300003726	ne	-/-	-/-
10	A,B	EMI Test Receiver 9kHz-26,5GHz	ESR26	R&S	101376	300005063	vIKI!	13.09.2016	13.03.2018

6.3 Conducted measurements

Conducted measurements normal conditions



OP = AV + CA
(OP-output power; AV-analyzer value; CA-loss signal path)

Example calculation:
OP [dBm] = 6.0 [dBm] + 11.7 [dB] = 17.7 [dBm] (58.88 mW)

Equipment table:

No.	Lab / Item	Equipment	Type	Manufacturer	Serial No.	INV. No.	Kind of Calibration	Last Calibration	Next Calibration
1	A	Power Supply	2X30V	Zentro	870008	300000830	NK!	-/-	-/-
2	A	EMI Test Receiver 9 kHz - 3 GHz incl. Preselector	ESPI3	R&S	101713	300004059	k	25.01.2017	24.01.2018
3	A	RF-Cable SRD021 No. 1	Enviroflex 316 D	Huber & Suhner		400001311	ev	01.02.2017	31.01.2018

7 Sequence of testing

7.1 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the premeasurement are maximized by the software by rotating the turntable from 0° to 360°. In case of the 2-axis positioner is used the elevation axis is also rotated from 0° to 360°.
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.

7.2 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position ± 45° and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

7.3 Sequence of testing radiated spurious 1 GHz to 12.75 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) – see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height is 1.5 m.
- At each turntable position and antenna polarization the analyzer sweeps with positive peak detector to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximizes the peaks by rotating the turntable from 0° to 360°. This measurement is repeated for different EUT-table positions (0° to 150° in 30°-steps) and for both antenna polarizations.
- The final measurement is done in the position (turntable, EUT-table and antenna polarization) causing the highest emissions with Peak and RMS detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, EUT-table position, antenna polarization, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

8 Measurement uncertainty

Measurement uncertainty	
Test case	**Uncertainty**
Antenna gain	± 3 dB
Spectrum bandwidth	± 21.5 kHz absolute; ± 15.0 kHz relative
Maximum field strength	± 1 dB
Spurious emissions radiated below 30 MHz	± 3 dB
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB
Spurious emissions radiated 1 GHz to 12.75 GHz	± 3.7 dB
Spurious emissions conducted below 30 MHz (AC conducted)	± 2.6 dB

9 Summary of measurement results

☒	No deviations from the technical specifications were ascertained
☐	There were deviations from the technical specifications ascertained
☐	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS - 210, Issue 9 RSS Gen Issue 4	See table!	2017-06-27	-/-

Test specification clause	Test case	Temperature conditions	Power source voltages	C	NC	NA	NP	Remark
§15.249(a) RSS 210	Field strength of emissions (wanted signal)	Nominal	Nominal	☒	☐	☐	☐	-/-
§2.1049 RSS 210	Occupied bandwidth (99% bandwidth)	Nominal	Nominal	☒	☐	☐	☐	-/-
§15.209(a) / §15.249(b)(1)(2)(3) RSS Gen	Field strength of emissions (spurious)	Nominal	Nominal	☒	☐	☐	☐	-/-
§15.207(a) RSS Gen	Conducted emissions < 30 MHz	Nominal	Nominal	☒	☐	☐	☐	-/-
§15.109 RSS Gen	Field strength of emissions (spurious)	Nominal	Nominal	☒	☐	☐	☐	-/-

Note: C = Compliant; NC = Not compliant; NA = Not applicable; NP = Not performed

10 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None

Test mode: ☐ Normal operation, no special test mode available.

☒ Special software is used.

11 Measurement results

11.1 Field strength of emissions (wanted signal)

Description:

Measurement of the maximum radiated field strength of the wanted signal.

Measurement:

Measurement parameter	
Detector:	Pos-Peak
Sweep time:	Auto
Video bandwidth:	Auto
Resolution bandwidth:	1 MHz
Span:	max. 100 MHz
Trace-Mode:	Max Hold
Test setup	See sub clause 6.1 A
Measurement uncertainty	See sub clause 8

Limits:

FCC / IC		
Field strength of emissions		
The field strength of emissions from intentional radiators operated within these frequency bands shall comply with the following:		
Frequency [MHz]	Field Strength [dBµV/m]	Measurement distance
902 – 928 MHz	94 (FCC) / 114 (IC)	3

Result:

CH 00:

Test condition	Maximum field strength	
	Frequency [MHz]	Field strength [dBµV/m] @ 3 m
T_{nom} / V_{nom}	916.0 MHz	90.4
Measurement uncertainty	± 3 dB	

CH 01:

Test condition	Maximum field strength	
	Frequency [MHz]	Field strength [dBµV/m] @ 3 m
T_{nom} / V_{nom}	908.4 MHz	90.3
Measurement uncertainty	± 3 dB	

11.2 Occupied bandwidth (99% bandwidth)

Description:

Measurement of the 99% bandwidth of the wanted signal.

Measurement:

Measurement parameter	
Detector:	Peak
Sweep time:	Auto
Video bandwidth:	1 kHz
Resolution bandwidth:	3 kHz
Span:	8 MHz
Trace-Mode:	Max Hold
Test setup	See sub clause 6.3A
Measurement uncertainty	See sub clause 8

Results:

908.4 MHz

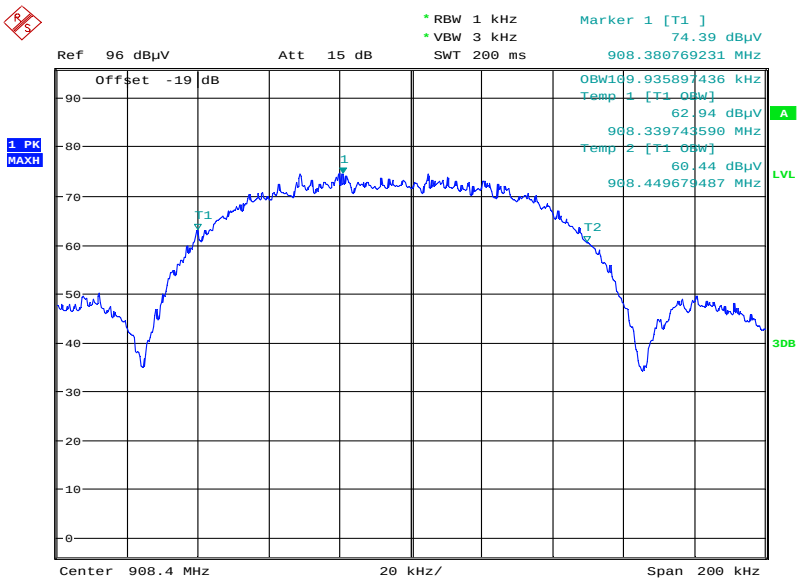
Test condition	Occupied bandwidth	
	Frequency [MHz]	Occupied bandwidth [kHz]
T_{nom} / V_{nom}	908.4	109.9
Measurement uncertainty	± 3 dB	

916.0 MHz

Test condition	Occupied bandwidth	
	Frequency [MHz]	Occupied bandwidth [kHz]
T_{nom} / V_{nom}	916.0	110.9
Measurement uncertainty	± 3 dB	

Plots:

Plot 1: 908.4 MHz



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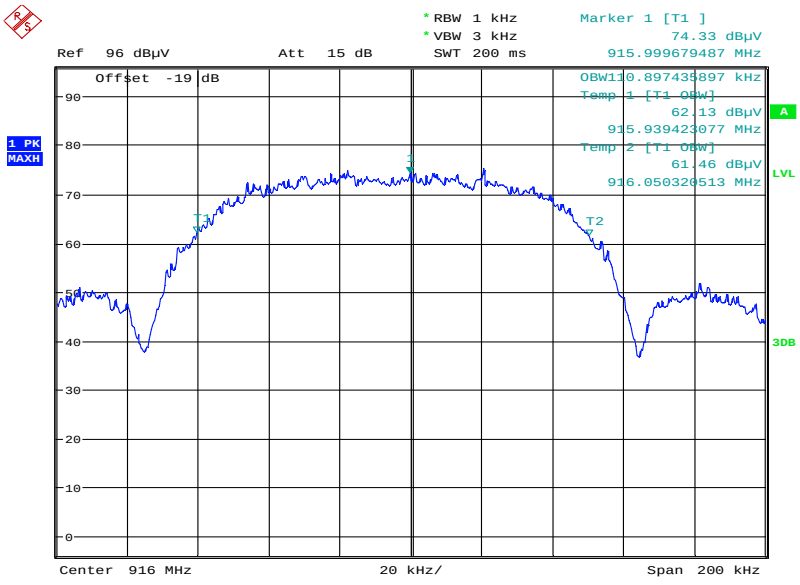
Plot 2: 916.0 MHz



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11.3 Spurious emissions radiated

11.3.1 Spurious emissions radiated below 30 MHz

Description:

Measurement of the radiated spurious emissions in transmit mode below 30 MHz. The limits are recalculated to a measurement distance of 3 m according the ANSI C63.10.

Measurement parameters	
Detector	Peak / Quasi peak
Sweep time	Auto
Resolution bandwidth	F < 150 kHz: 200 Hz F > 150 kHz: 9 kHz
Video bandwidth	F < 150 kHz: 1 kHz F > 150 kHz: 30 kHz
Span	9 kHz to 30 MHz
Trace mode	Max hold
Test setup	See sub clause 6.2 A
Measurement uncertainty	See sub clause 8

Limits:

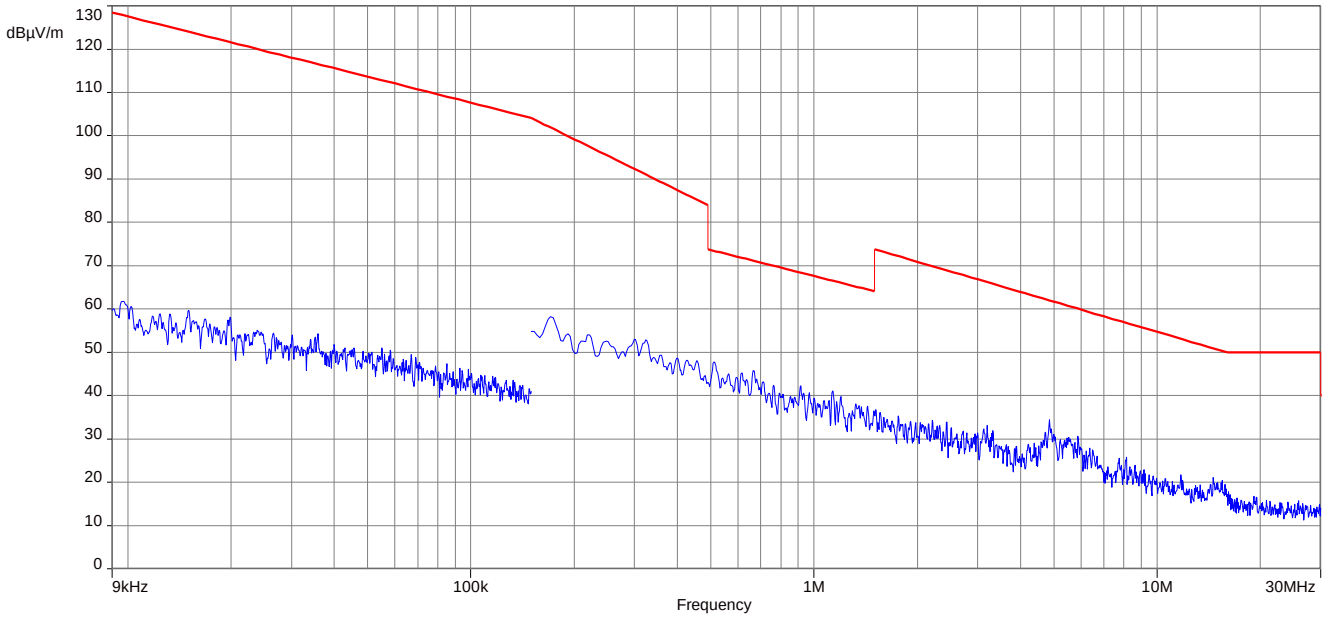
FCC		IC
TX spurious emissions radiated below 30 MHz		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance
0.009 – 0.490	2400/F(kHz)	300
0.490 – 1.705	24000/F(kHz)	30
1.705 – 30.0	30	30

Results:

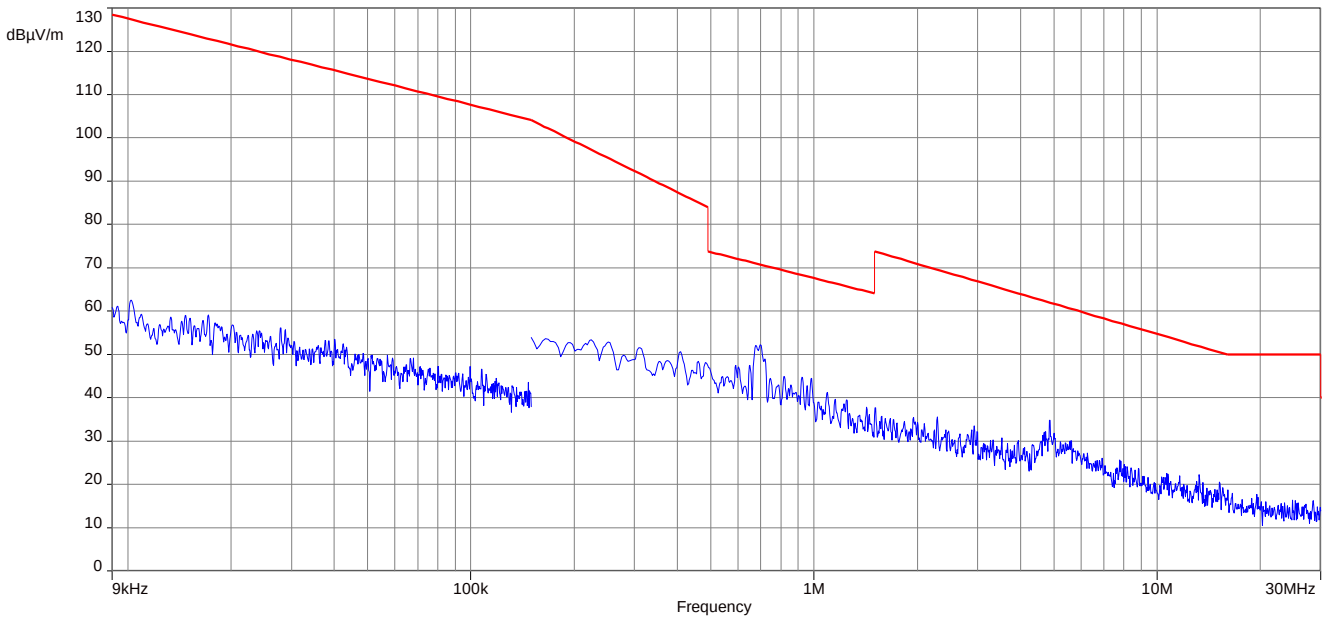
TX spurious emissions radiated below 30 MHz [dBµV/m]		
F [MHz]	Detector	Level [dBµV/m]
All detected emissions are more than 20 dB below the limit.		

Plots:

Plot 1: 9 kHz to 30 MHz, 908.4 MHz



Plot 2: 9 kHz to 30 MHz, 916.0 MHz



11.3.2 Spurious emissions radiated 30 MHz to 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode.

Measurement parameters	
Detector	Peak / Quasi Peak
Sweep time	Auto
Resolution bandwidth	120 kHz
Video bandwidth	3 x RBW
Span	30 MHz to 1 GHz
Trace mode	Max hold
Measured modulation	O-QPSK
Test setup	See sub clause 6.1 A
Measurement uncertainty	See sub clause 8

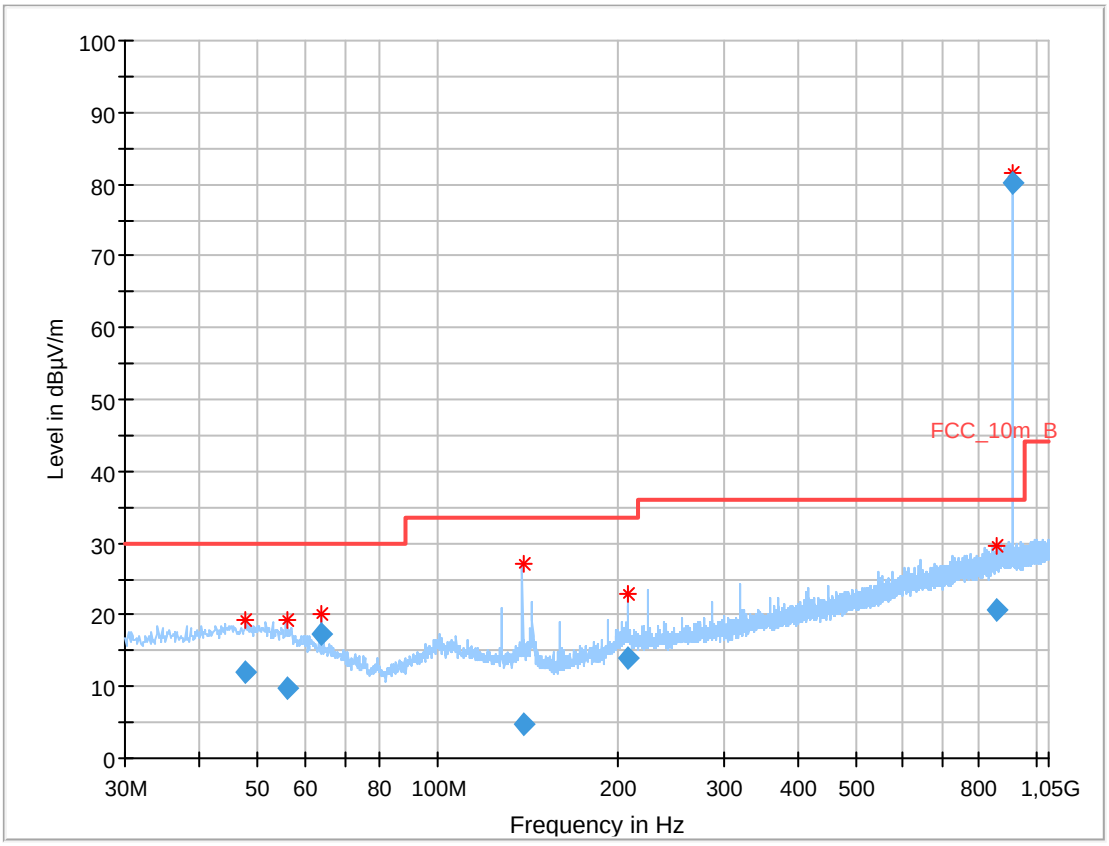
The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC		IC
TX spurious emissions radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
§15.209		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance
30 - 88	30.0	10
88 – 216	33.5	10
216 – 960	36.0	10
Above 960	54.0	3

Plots:

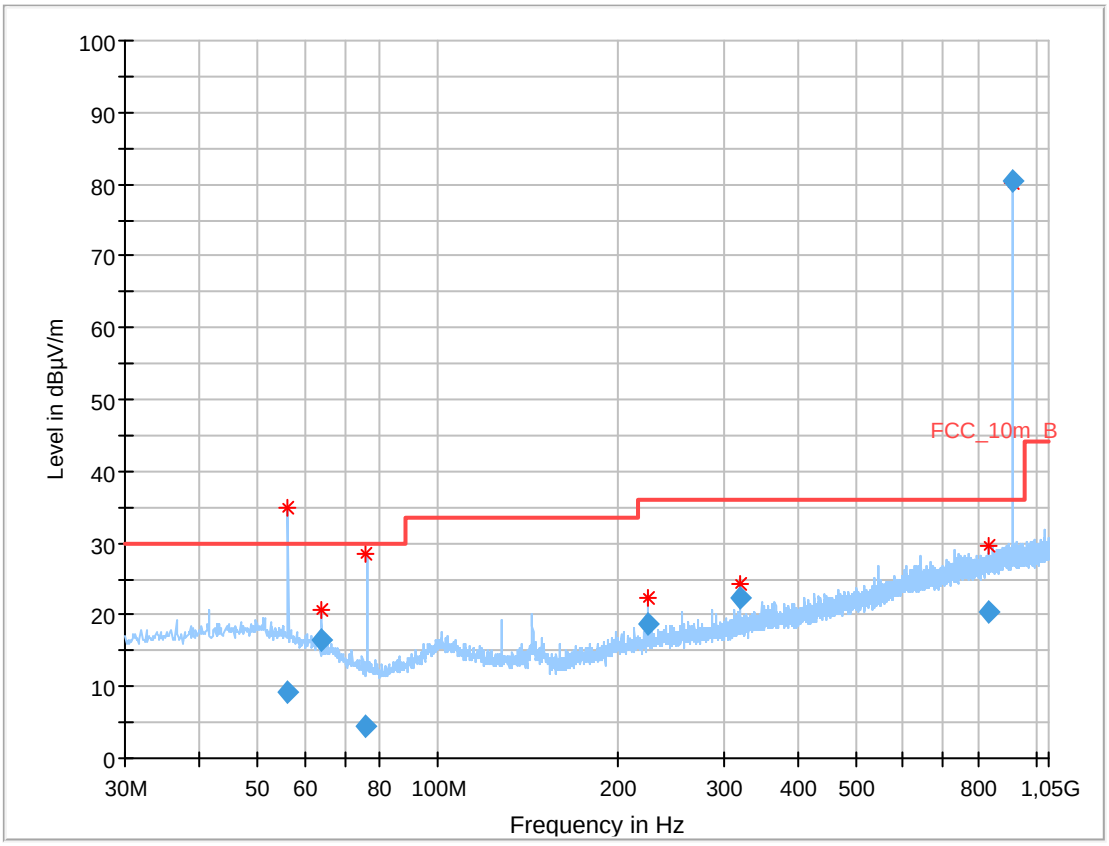
Plot 1: 30 MHz to 1 GHz, TX mode, 908.4 MHz, vertical & horizontal polarization



Final_Result QP

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
47.709750	12.03	30.00	17.97	1000.0	120.000	103.0	V	75.0	13.7
55.825800	9.87	30.00	20.13	1000.0	120.000	200.0	V	303.0	12.9
63.991650	17.35	30.00	12.65	1000.0	120.000	103.0	V	300.0	11.0
138.692850	4.87	33.50	28.63	1000.0	120.000	101.0	H	-15.0	8.9
207.994800	13.84	33.50	19.66	1000.0	120.000	101.0	V	303.0	12.2
856.362150	20.69	36.00	15.31	1000.0	120.000	104.0	H	75.0	23.6

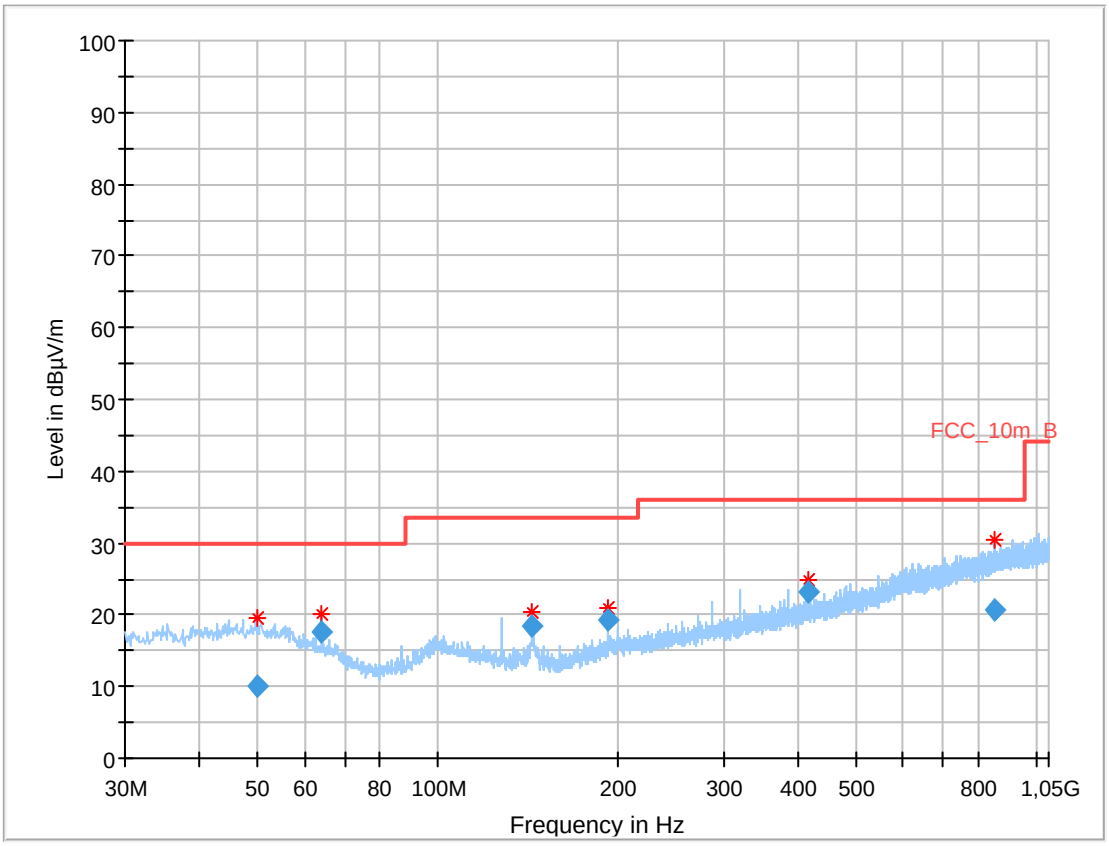
Plot 2: 30 MHz to 1 GHz, TX mode, 916.0 MHz, vertical & horizontal polarization



Final_Result QP

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
56.164050	9.30	30.00	20.70	1000.0	120.000	101.0	H	168.0	12.8
64.005750	16.58	30.00	13.42	1000.0	120.000	103.0	V	76.0	11.0
75.847650	4.59	30.00	25.41	1000.0	120.000	104.0	H	165.0	8.7
224.002950	18.83	36.00	17.17	1000.0	120.000	100.0	V	-13.0	12.7
320.013600	22.48	36.00	13.52	1000.0	120.000	203.0	H	211.0	15.1
834.697200	20.35	36.00	15.65	1000.0	120.000	98.0	H	120.0	23.3

Plot 3: 30 MHz to 1 GHz, RX mode, vertical & horizontal polarization



Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
49.885050	10.10	30.00	19.90	1000.0	120.000	203.0	V	255.0	13.7
64.004700	17.62	30.00	12.38	1000.0	120.000	203.0	V	75.0	11.0
143.999700	18.34	33.50	15.16	1000.0	120.000	100.0	V	210.0	9.0
192.003150	19.40	33.50	14.10	1000.0	120.000	100.0	V	121.0	11.5
415.998000	23.19	36.00	12.81	1000.0	120.000	103.0	H	77.0	17.1
855.159600	20.58	36.00	15.42	1000.0	120.000	200.0	H	211.0	23.6

11.3.3 Spurious emissions radiated above 1 GHz

Description:

Measurement of the radiated spurious emissions in transmit mode.

Measurement parameters	
Detector	Peak / RMS
Sweep time	Auto
Resolution bandwidth	1 MHz
Video bandwidth	3 x RBW
Span	1 GHz to 12.75 GHz
Trace mode	Max hold
Measured modulation	2-FSK
Test setup	See sub clause 6.2 B
Measurement uncertainty	See sub clause 8

The modulation with the highest output power was used to perform the transmitter spurious emissions. If spurious were detected a re-measurement was performed on the detected frequency with each modulation.

Limits:

FCC		IC
TX spurious emissions radiated		
In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).		
§15.209 / RSS Gen.		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance
Above 960	54.0 (Average)	3
Above 960	74.0 (Peak)	3

RSS-210		
Frequency (MHz)	Field strength (dBµV/m)	Measurement distance
Harmonics	64.1 (Average)	3

Result:

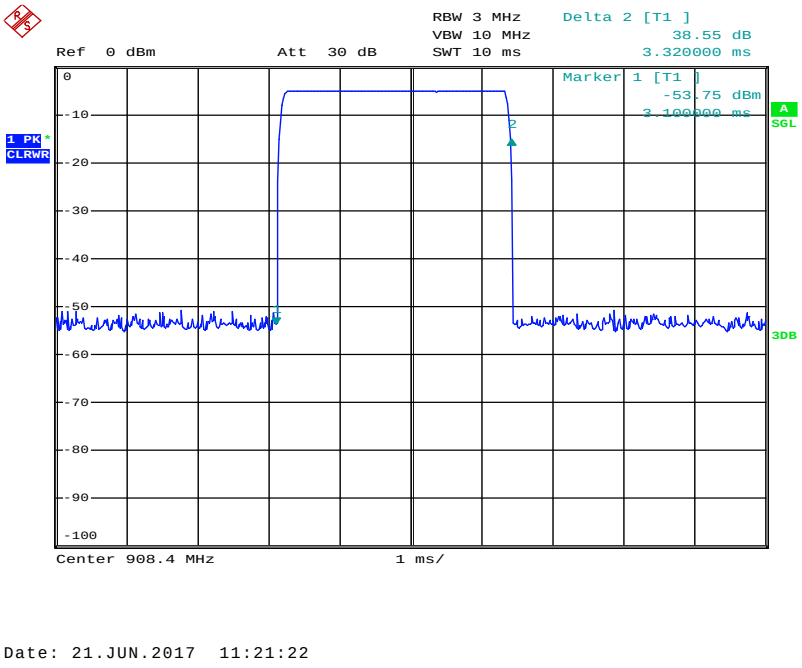
For radiated spurious emission the limits of 15.209 applies for all frequencies mentioned in 15.205. According to FCC Public Notice DA 00-705 (ANSI C63.10) the average emission shall be determined by using RMS detector. If the dwell time of the hopping signal is less than 100 ms (per channel), the RMS reading may be adjusted by a factor:

F = 20*log (dwell time/100 ms)

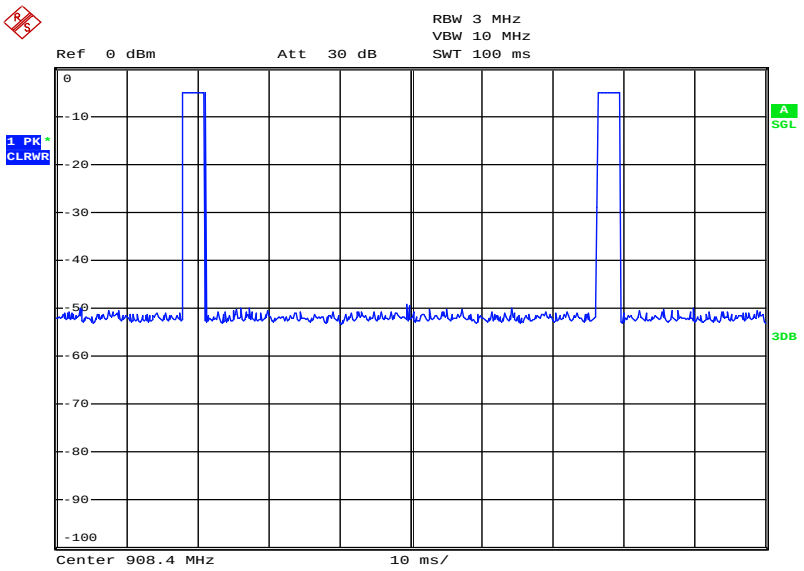
In a period of 100 ms, we have a maximum of 2 transmissions and that gives the correction factor for spurious measurement.

F = 20*log (2*3.32/100) = -23.6 dB

Plot 1: Time slot length = 3.32 ms



Plot 2: Number of bursts in 100ms = 2



Results: Transmitter mode

TX spurious emissions radiated [dBµV/m]								
908.4 MHz			916 MHz			-/-		
F [MHz]	Detector	Level [dBµV/m]	F [MHz]	Detector	Level [dBµV/m]	F [MHz]	Detector	Level [dBµV/m]
2720	Peak	55.2	2748	Peak	60.8		Peak	
	AVG*	31.6		AVG*	37.2		AVG*	
11805	Peak	53.9	4580	Peak	54.4		Peak	
	AVG*	30.3		AVG*	30.8		AVG*	
	Peak		11908	Peak	53.8		Peak	
	AVG*			AVG*	30.2		AVG*	

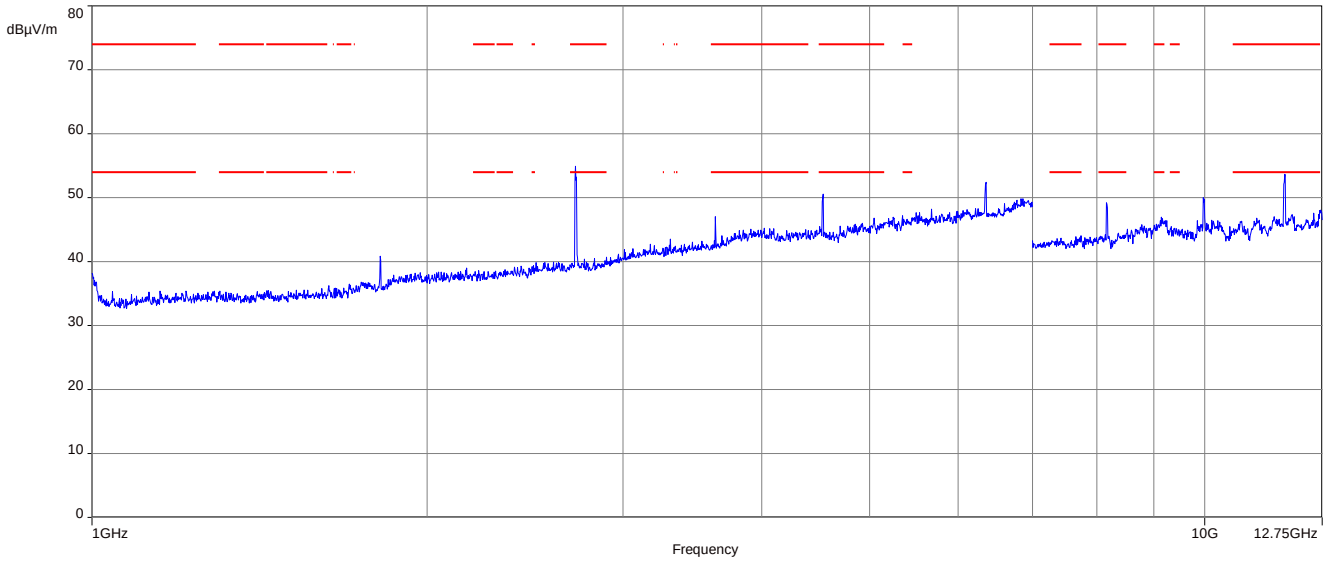
*Values recalculated with a DC correction factor of -23.6

Results: Receiver mode

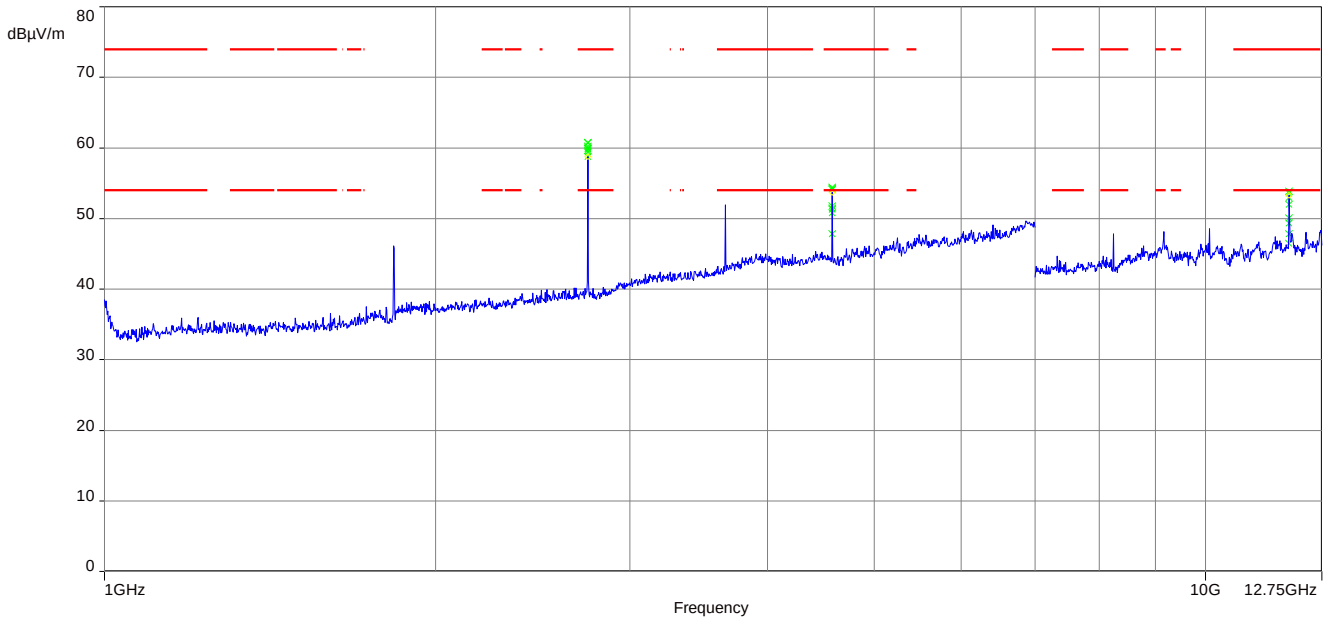
RX spurious emissions radiated [dBµV/m]		
F [MHz]	Detector	Level [dBµV/m]
All detected emissions are more than 20 dB below the limit.		

Plots:

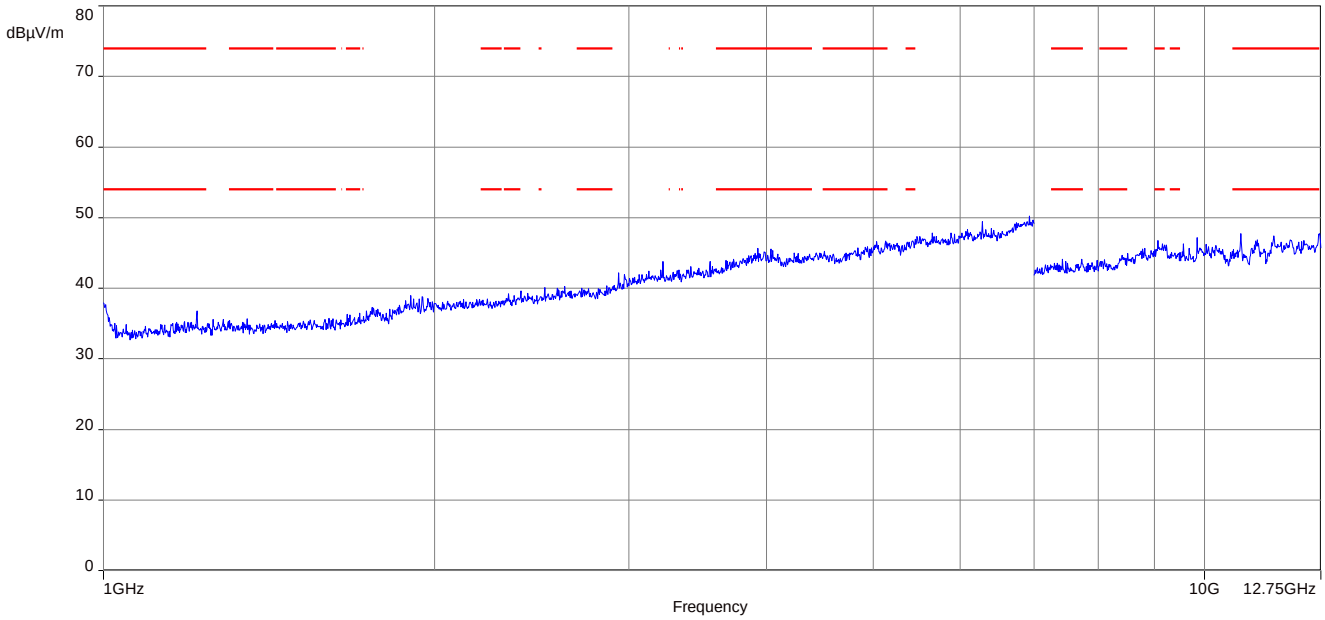
Plot 1: 1 GHz to 12.75 GHz, TX mode, 908.4 MHz, vertical & horizontal polarization



Plot 2: 1 GHz to 12.75 GHz, TX mode, 916.0 MHz, vertical & horizontal polarization



Plot 3: 1 GHz to 12.75 GHz, RX mode, vertical & horizontal polarization



12 Observations

No observations except those reported with the single test cases have been made.

1 Document history

Version	Applied changes	Date of release
	Initial release	2017-06-27

2 Further information

Glossary

AVG	-	Average
DUT	-	Device under test
EMC	-	Electromagnetic Compatibility
EN	-	European Standard
EUT	-	Equipment under test
ETSI	-	European Telecommunications Standard Institute
FCC	-	Federal Communication Commission
FCC ID	-	Company Identifier at FCC
HW	-	Hardware
IC	-	Industry Canada
Inv. No.	-	Inventory number
N/A	-	Not applicable
PP	-	Positive peak
QP	-	Quasi peak
S/N	-	Serial number
SW	-	Software
PMN	-	Product marketing name
HMN	-	Host marketing name
HVIN	-	Hardware version identification number
FVIN	-	Firmware version identification number
OBW		Occupied Bandwidth
OC		Operating Channel
OCW		Operating Channel Bandwidth
OOB		Out Of Band

3 Accreditation Certificate

first page

DAkkS Deutsche Akkreditierungsstelle

Deutsche Akkreditierungsstelle GmbH

Beliehene gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV
Unterzeichnerin der Multilateralen Abkommen
von EA, ILAC und IAF zur gegenseitigen Anerkennung

Akkreditierung

Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium

CTC advanced GmbH
Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

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Produktsicherheit
SAR / EMF
Umwelt
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Bluetooth®
Automotive
Wi-Fi-Services
Kanadische Anforderungen
US-Anforderungen
Akustik
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Registrierungsnummer der Urkunde: **D-PL-12076-01-01**

Frankfurt, 25.11.2016

Im Auftrag Dipl.-Ing. (FH) Ralf Egner
Abteilungsleiter

last page

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